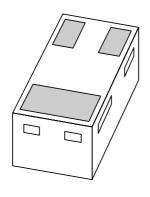
## **DISCRETE SEMICONDUCTORS**

# DATA SHEET



**PBSS2540M** 40 V, 0.5 A NPN low  $V_{CEsat}$  (BISS) transistor

Product data sheet 2003 Jul 22



# 40 V, 0.5 A NPN low V<sub>CEsat</sub> (BISS) transistor

## **PBSS2540M**

#### **FEATURES**

- Low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability I<sub>C</sub> and I<sub>CM</sub>
- High efficiency leading to reduced heat generation
- Reduced printed-circuit board requirements.

### **APPLICATIONS**

- Power management:
  - DC-DC converter
  - Supply line switching
  - Battery charger
  - LCD backlighting.
- · Peripheral driver:
  - Driver in low supply voltage applications (e.g. lamps and LEDs).
  - Inductive load drivers (e.g. relays, buzzers and motors).

### **DESCRIPTION**

Low  $V_{\text{CEsat}}$  NPN transistor in a SOT883 leadless ultra small plastic package.

PNP complement: PBSS3540M.

#### **MARKING**

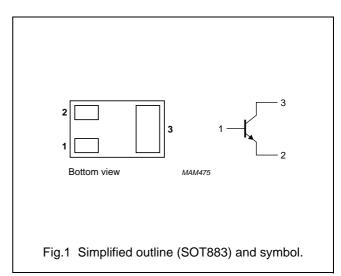
TYPE NUMBER	MARKING CODE
PBSS2540M	DC

#### **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	MAX.	UNIT
V <sub>CEO</sub>	collector-emitter voltage	40	V
I <sub>C</sub>	collector current (DC)	500	mA
I <sub>CM</sub>	peak collector current	1	Α
R <sub>CEsat</sub>	equivalent on-resistance <500 m		mΩ

### **PINNING**

PIN	DESCRIPTION	
1	base	
2	emitter	
3	collector	



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#### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	_	40	V
$V_{CEO}$	collector-emitter voltage	open base	_	40	V
V <sub>EBO</sub>	emitter-base voltage	open collector	_	6	V
I <sub>C</sub>	collector current (DC)	notes 1 and 2	_	500	mA
I <sub>CM</sub>	peak collector current		_	1	Α
I <sub>BM</sub>	peak base current		_	100	mA
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C; notes 1 and 2	_	250	mW
		T <sub>amb</sub> ≤ 25 °C; note 1 and 3	_	430	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
T <sub>j</sub>	junction temperature		_	150	°C
T <sub>amb</sub>	operating ambient temperature		-65	+150	°C

#### **Notes**

- 1. Refer to SOT883 standard mounting conditions.
- 2. Device mounted on an FR4 printed-circuit board, single-sided copper, tinplated, standard footprint, with 60  $\mu$ m copper strip line.
- 3. Device mounted on a printed-circuit board, single-sided copper, tinplated, mounting pad for collector 1 cm<sup>2</sup>.

## THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-a</sub>	thermal resistance from junction to	in free air; notes 1 and 2	500	K/W
	ambient	in free air; notes 1, 3 and 4	290	K/W

#### **Notes**

- 1. Refer to SOT883 standard mounting conditions.
- 2. Device mounted on an FR4 printed-circuit board, single-sided copper, tinplated, standard footprint, with 60  $\mu$ m copper strip line.
- 3. Device mounted on a printed-circuit board, single-sided copper, tinplated, mounting pad for collector 1 cm<sup>2</sup>.
- 4. Operated under pulsed conditions: duty cycle  $\delta \leq$  20%, pulse width  $t_p \leq$  30 ms.

## Soldering

Reflow soldering is the only recommended soldering method.

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### **CHARACTERISTICS**

 $T_{amb}$  = 25  $^{\circ}C$  unless otherwise specified.

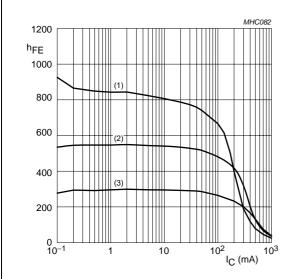
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I <sub>CBO</sub>	collector-base cut-off current	V <sub>CB</sub> = 30 V; I <sub>E</sub> = 0	_	_	100	nA
		V <sub>CB</sub> = 30 V; I <sub>E</sub> = 0; T <sub>j</sub> = 150 °C	_	_	50	μΑ
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = 5 \text{ V}; I_{C} = 0$	_	-	100	nA
h <sub>FE</sub>	DC current gain	$V_{CE} = 2 \text{ V}; I_{C} = 10 \text{ mA}$	200	_	_	
		V <sub>CE</sub> = 2 V; I <sub>C</sub> = 100 mA; note 1	150	_	_	
		$V_{CE} = 2 \text{ V}; I_{C} = 500 \text{ mA}; \text{ note 1}$	50	_	_	
$V_{CEsat}$	collector-emitter saturation voltage	$I_C = 10 \text{ mA}; I_B = 0.5 \text{ mA}$	_	_	50	mV
		$I_C = 100 \text{ mA}; I_B = 5 \text{ mA}$	_	_	100	mV
		$I_C = 200 \text{ mA}$ ; $I_B = 10 \text{ mA}$ ; note 1	_	_	200	mV
		$I_C = 500 \text{ mA}$ ; $I_B = 50 \text{ mA}$ ; note 1	_	_	250	mV
R <sub>CEsat</sub>	equivalent on-resistance	$I_C = 500 \text{ mA}$ ; $I_B = 50 \text{ mA}$ ; note 1	_	380	<500	mΩ
V <sub>BEsat</sub>	base-emitter saturation voltage	$I_C = 500 \text{ mA}$ ; $I_B = 50 \text{ mA}$ ; note 1	_	-	1.2	V
$V_{BEon}$	base-emitter turn-on voltage	V <sub>CE</sub> = 2 V; I <sub>C</sub> = 100 mA; note 1	_	_	1.1	V
f <sub>T</sub>	transition frequency	I <sub>C</sub> = 100 mA; V <sub>CE</sub> = 5 V; f = 100 MHz	250	450	_	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = I_e = 0; f = 1 \text{ MHz}$	-	=	6	pF

## Note

1. Pulse test:  $t_p \le 300~\mu s;~\delta \le 0.02.$ 

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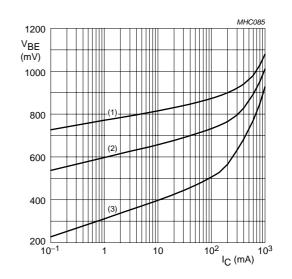
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 $V_{CE} = 2 V$ .

- (1)  $T_{amb} = 150 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = -55 \, ^{\circ}C$ .

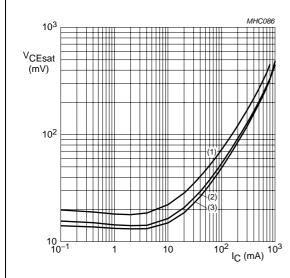
Fig.2 DC current gain as a function of collector current; typical values.



 $V_{CE} = 2 V.$ 

- (1)  $T_{amb} = -55 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = 150 \, ^{\circ}C$ .

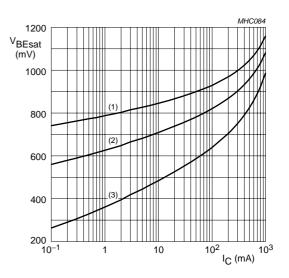
Fig.3 Base-emitter voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B} = 20.$ 

- (1)  $T_{amb} = 150 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = -55 \, ^{\circ}C$ .

Fig.4 Collector-emitter saturation voltage as a function of collector current; typical values.



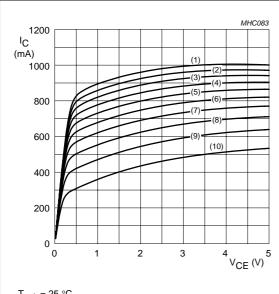
 $I_{\rm C}/I_{\rm B} = 20$ .

- (1)  $T_{amb} = 150 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = -55 \, ^{\circ}C$ .

Fig.5 Base-emitter saturation voltage as a function of collector current; typical values.

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 $T_{amb} = 25 \, ^{\circ}C.$ 

(1)  $I_B = 25 \text{ mA}.$ 

(5)  $I_B = 15 \text{ mA}.$ 

(9)  $I_B = 5 \text{ mA}.$ 

(2)  $I_B = 22.5 \text{ mA}.$ 

(6)  $I_B = 12.5 \text{ mA}.$ 

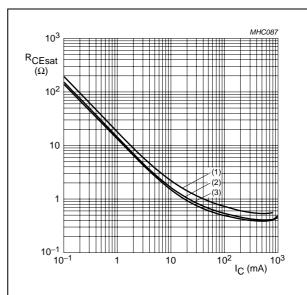
(10)  $I_B = 2.5 \text{ mA}$ .

(3)  $I_B = 20 \text{ mA}$ .

(7)  $I_B = 10 \text{ mA}.$ (8)  $I_B = 7.5 \text{ mA}.$ 

(4)  $I_B = 17.5 \text{ mA}.$ 

Fig.6 Collector current as a function of collector-emitter voltage; typical values.



 $I_{\rm C}/I_{\rm B}=20.$ 

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(1)  $T_{amb} = 150 \, ^{\circ}C$ .

(2)  $T_{amb} = 25 \, ^{\circ}C$ .

(3)  $T_{amb} = -55 \, ^{\circ}C$ .

Fig.7 Collector-emitter equivalent on-resistance as a function of collector current; typical

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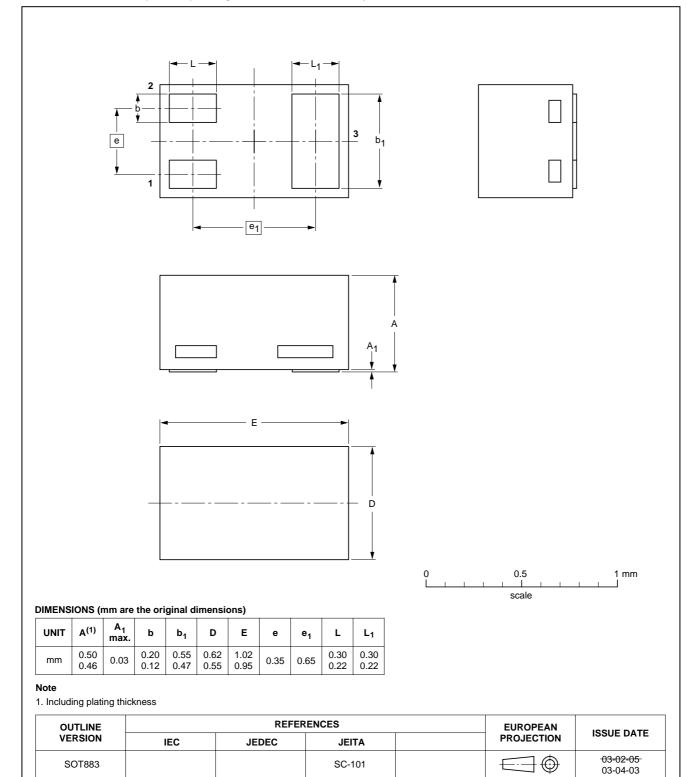
40 V, 0.5 A NPN low  $V_{CEsat}$  (BISS) transistor

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### **PACKAGE OUTLINE**

Leadless ultra small plastic package; 3 solder lands; body 1.0 x 0.6 x 0.5 mm

**SOT883** 



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DOCUMENT STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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